Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/541,841	FUJITA ET AL.	
Examiner	Art Unit	
Emily Chimiak	1733	

SEARCHED			
Class	Subclass	Date	Examiner
156	89.22	5/11/2007	EAC

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
		.		

SEAR (INCLUDING S	CH NOTE	ES TRATEGY))
		DATE	EXMR
156/89.22.ccls.	·	5/11/2007	EAC